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ATTORNEY DOCKET NO. FIRST NAMED INVENTOR APPLICATION NO. **FILING DATE** 2933SE-11-CI 09/037,674 03/09/98 **MIZUHARA EXAMINER** MM92/0412 022442 NADALAT UNIT PAPER NUMBER SHERIDAN ROSS PC 1560 BROADWAY **SUITE 1200** 2804 MAILED: **DENVER CO 80202** 04/12/00

Please find below and/or attached an Office communication concerning this application or proceeding.

PTO-90C (Rev. 2/95)

Commissioner of Patents and Trademarks

U.S. G.P.O. 1999 460-693

Office Action Summary

Application No. 09/037,674

Applicant(s)

Mizuhara et al.

Examiner

ORI NADAV

Group Art Unit 2811



Responsive to communication(s) filed on Mar 10, 2000	
☐ This action is FINAL .	
☐ Since this application is in condition for allowance except for for in accordance with the practice under <i>Ex parte Quayle</i> , 1935 (
A shortened statutory period for response to this action is set to e is longer, from the mailing date of this communication. Failure to application to become abandoned. (35 U.S.C. § 133). Extension: 37 CFR 1.136(a).	respond within the period for response will cause the
Disposition of Claims	
	is/are pending in the application.
Of the above, claim(s) 16-24	is/are withdrawn from consideration.
Claim(s)	
Claim(s)	
☐ Claims	
Application Papers	
See the attached Notice of Draftsperson's Patent Drawing F	Review, PTO-948.
☐ The drawing(s) filed on is/are objected	
☐ The proposed drawing correction, filed on	•
☐ The specification is objected to by the Examiner.	
$\hfill\Box$ The oath or declaration is objected to by the Examiner.	
Priority under 35 U.S.C. § 119	
☐ Acknowledgement is made of a claim for foreign priority un	nder 35 U.S.C. § 119(a)-(d).
☐ All ☐ Some* ☐ None of the CERTIFIED copies of t	he priority documents have been
☐ received.	
received in Application No. (Series Code/Serial Numb	
received in this national stage application from the In	
*Certified copies not received: Acknowledgement is made of a claim for domestic priority	
☐ Acknowledgement is made of a claim for domestic priority	under 35 U.S.C. § 119(e).
Attachment(s)	
Notice of References Cited, PTO-892	c) 2-14
☑ Information Disclosure Statement(s), PTO-1449, Paper No(s) ☐ Interview Summary, PTO-413	al <u> </u>
☐ Notice of Draftsperson's Patent Drawing Review, PTO-948	
☐ Notice of Informal Patent Application, PTO-152	
SEE OFFICE ACTION ON THE	E FOLLOWING PAGES

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DETAILED ACTION

Election/Restriction

1. Applicant's election of claims 1-15 in Paper No. 15 is acknowledged. Because applicant did not distinctly and specifically point out the supposed errors in the restriction requirement, the election has been treated as an election without traverse (MPEP § 818.03(a)).

Claim Objections

2. Claims 7 and 12 are objected to because of the following informalities: The phrase "lower than the first insulating film" should read "lower than that of the first insulating film".

Appropriate correction is required.

Claim Rejections - 35 USC § 103

- 3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

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4. Claims 1, 3-8, 10-13 and 15 are rejected under 35 U.S.C. 103(a) as being unpatentable

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over Okumura et al. (4,984,055) in view of Ito et al. (5,270,259).

Okumura et al. teach in figure 13D a semiconductor device comprising a semiconductor substrate

1, wirings 17 located on the substrate, and a passivation layer located on the wirings, including a

first SOG insulating film 13 containing boron impurities (column 10, lines 55-56), and a second

silicon oxide insulating film 12 being located on at least one of an upper side and a lower side of

the first insulating film.

Okumura et al. do not disclose whether the SOG layer is an organic SOG (i.e. containing over 1%

carbon) or inorganic SOG layer.

Ito et al. teach that an SOG layer comprising an organic SOG and an inorganic SOG layers,

respectively. It would have been obvious to a person of ordinary skill in the art at the time the

invention was made to use an SOG layer comprising an organic SOG and an inorganic SOG in

Okumura et al.'s device, because each of the organic and inorganic SOG layers has its own

advantages, and the choice of using an organic or inorganic SOG layer depends on the

requirements of the application in hand.

Regarding claims 7 and 12, the second insulating film has a hygroscopicity lower than the first

insulating film.

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5. Claims 2, 9 and 14 are rejected under 35 U.S.C. 103(a) as being unpatentable over

Okumura et al. and Ito et al., as applied to claims 1, 5 and 11 above, and further in view of

Yoshimori et al. (5,468,684).

Okumura et al. and Ito et al. teach substantially the entire claimed structure, as above, except an

impurity selected from a group consisting of argon, nitrogen and phosphorus.

Yoshimori et al. teach an impurity selected from a group consisting of argon, nitrogen and

phosphorus (column 16, lines 13-18).

It would have been obvious to a person of ordinary skill in the art at the time the invention was

made to use an impurity selected from a group consisting of argon, nitrogen and phosphorus in

Okumura et al.'s device, because argon, nitrogen and phosphorus are known impurities used

conventionally in the art.

Papers related to this application may be submitted to Technology center (TC) 2800 by

facsimile transmission. Papers should be faxed to TC 2800 via the TC 2800 Fax center

located in Crystal Plaza 4, room 4-C23. The faxing of such papers must conform with the

notice published in the Official Gazette, 1096 OG 30 (November 15, 1989). The Group

2811 Fax Center number is (703) 308-7722 and 308-7724. The Group 2811 Fax Center is to

be used only for papers related to Group 2811 applications.

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Any inquiry concerning this communication or any earlier communication from the Examiner should be directed to *Examiner Nadav* whose telephone number is **(703) 308-8138**. The Examiner is in the Office generally between the hours of 7 AM to 3 PM (Eastern Standard Time) Monday through Friday.

Any inquiry of a general nature or relating to the status of this application should be directed to the **Technology Center Receptionists** whose telephone number is **308-0956**

Tom Thomas Suparvisory ^{re}atent Examiner Testinology Conter 2800

Ori Nadav, Ph.D.

April 4, 2000